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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/775,254	02/11/2004	Hiroshi Iwata	0397-0475P	9897
2292	7590 06/22/2006		EXAMINER	
BIRCH STEWART KOLASCH & BIRCH			NGUYEN, TAN	
PO BOX 747 FALLS CHURCH, VA 22040-0747			ART UNIT	PAPER NUMBER
			2827	
	•		DATE MAILED: 06/22/2006	6

Please find below and/or attached an Office communication concerning this application or proceeding.

				(1)
		Application No.	Applicant(s)	
		10/775,254	IWATA ET AL.	
	Office Action Summary	Examiner	Art Unit	
		Tan T. Nguyen	2827	
 Period for	The MAILING DATE of this communication app Reply	ears on the cover sheet v	vith the correspondence address	
WHICH - Extensi after SI - If NO po - Failure Any rep	RTENED STATUTORY PERIOD FOR REPLY IEVER IS LONGER, FROM THE MAILING DA ons of time may be available under the provisions of 37 CFR 1.13 X (6) MONTHS from the mailing date of this communication. eriod for reply is specified above, the maximum statutory period w to reply within the set or extended period for reply will, by statute, ly received by the Office later than three months after the mailing patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUN 36(a). In no event, however, may a rill apply and will expire SIX (6) MC cause the application to become A	ICATION. reply be timely filed NTHS from the mailing date of this communication. ABANDONED (35 U.S.C. § 133).	
Status		•		
1)⊠ R	desponsive to communication(s) filed on <u>08 Ju</u>	ne 2006.		
2a)⊠ T	his action is FINAL . 2b) This	action is non-final.		
	ince this application is in condition for allowar	·		
С	losed in accordance with the practice under E	x parte Quayle, 1935 C.	D. 11, 453 O.G. 213.	
Dispositio	n of Claims			
4)⊠ C	claim(s) <u>1,2 and 4-22</u> is/are pending in the app	olication.		
	a) Of the above claim(s) is/are withdraw	vn from consideration.		
• ====	claim(s) <u>10-22</u> is/are allowed.			
·	Claim(s) 1-2, 4-9 is/are rejected.			
·	Claim(s) is/are objected to. Claim(s) are subject to restriction and/or	election requirement		
0) 0	maini(s) are subject to restriction and/or	cicolon requirement.		
Application	n Papers			
•	ne specification is objected to by the Examine			
•	ne drawing(s) filed on is/are: a) acce	· · · · · · · · · · · · · · · · · · ·		
	pplicant may not request that any objection to the	•		
	teplacement drawing sheet(s) including the correctine oath or declaration is objected to by the Ex	•		
		ammer. Note the attach	of Chick Notion of John 1 10 102.	
•	der 35 U.S.C. § 119			
-	cknowledgment is made of a claim for foreign	priority under 35 U.S.C.	§ 119(a)-(d) or (f).	
•	All b) Some * c) None of:			
·	 Certified copies of the priority documents Certified copies of the priority documents 		Application No.	
	 Certified copies of the priority documents Copies of the certified copies of the prior 		• •	
J	application from the International Bureau	·	Trecorred in this Matiental Claye	
* Se	e the attached detailed Office action for a list		t received.	
				•
Attachment(s	s)			
	of References Cited (PTO-892)		Summary (PTO-413)	
3) Informa	of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) No(s)/Mail Date		v(s)/Mail Date Informal Patent Application (PTO-152) 	

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1. The amendment submitted by Applicant on June 8, 2006 has been received and entered.

- 2. Claims 1-2 and 4-22 are pending.
 - Claim 3 has been canceled.
- 3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 4. Claims 1, 4-9 are rejected under 35 U.S.C. 102(b) as being anticipated by Sakagami et al. (U.S. Patent No. 5,838,041).

Sakagami et al. disclosed in Figure 2 a nonvolatile memory cell comprising on a semiconductor substrate [1] a gate electrode (control gate) [13] is formed. Under the gate electrode [13], formed is an insulating layer [11] is made of silicon oxide film. On the surface of the substrate [1], source/drain regions are formed with the gate electrode [13] interposed therebetween. A diffusion layer [21] is a source in which an offset region is provided. Diffusion layers [16] and [20] are lightly doped drain structure. On the channel region between an edge of the gate electrode [13] and the diffusion layer [21], a layered film consisting of silicon oxide film [14] and a SiN film [17] is provided. The SiN film [17] is interposed between the silicon oxide films [14] and [18], constituting a sidewall [19] of the gate electrode [13]. The SiN film [17] is a charge accumulating layer. Each of the diffusion layers [20] and [21] is formed so as to overlap with the neighbor of the lower edge portion of the sidewall [19]. Contact plugs [25] connect an

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upper layer, namely, Al wiring to the source (diffusion layer [21]) and to the drain (diffusion layer [20]) respectively (column 4, lines 6-35). Conventionally, the Al wiring [26] are coupled to sense amplifier. The sidewall [19] would be understood as the claimed memory functional units, which have the SiN film for retaining charge, and the silicon oxide films [14], [18] for insulating film.

Regarding claim 4, as shown in Figure 2, the SiN film [17] having a surface parallel with the surface of the insulating film [11].

Regarding claim 5, as shown in Figure 2, the SiN film [17] is disposed substantially parallel with the side face of the gate electrode [13].

Regarding claims 6-7, since Applicant claimed the insulating film of the memory functional units has a thickness of 0.8 nm or more, or 20 nm or less, respectively, , Sakagami et al. disclosed the oxide film [14] should have a thickness less than 10 nm (column 4, lines 63-64).

Regarding claims 8-9, the claims are directed to the intended uses of the memory cell device. The memory device disclosed by Sakagami would be used in any portable electronic devices.

- 5. Claims 10-22 are allowed.
- 6. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Chang is cited to show memory cell having charge trapping layer on the side of the gate electrode.

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7. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

8. **REMARKS**

Applicant amended claims 1 and 10 by adding "being an insulator containing a silicon nitride" which was not presented in the original claims. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tan T. Nguyen whose telephone number is (571) 272-1789. The examiner can normally be reached on Monday to Friday from 07:00 AM to 03:00 PM.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amir Zarabian, can be reached at (571) 272-1852. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Tan T. Nguyen Primary Examiner Art Unit 2827 June 16, 2006 Page 5